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# N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}$ (m $\Omega$ ) (Typ.)	I <sub>D</sub> (A) <sup>a,e</sup>	Q <sub>g</sub> (Typ.)		
60	13 at V <sub>GS</sub> = 10 V	35	15.3 nC		
00	15.5 at V <sub>GS</sub> = 4.5 V	30	15.5 110		

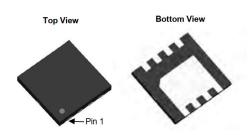
#### **FEATURES**

- **DT-Trench Power MOSFET**
- 100 % Rg and UIS Tested
- AEC-Q101 Qualified for **Automotive Applications**

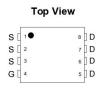


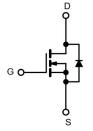
### **APPLICATIONS**

- Notebook PC Core
- VRM/POL



DFN 3x3 EP





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	(T <sub>A</sub> = 25 °C, unle	ess otherwise	noted)		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	60	V		
Gate-Source Voltage		V <sub>GS</sub>	± 20	V	
	T <sub>C</sub> = 25 °C	I <sub>D</sub>	35 <sup>a, e</sup>		
Continuous Drain Current (T <sub>.I</sub> = 175 °C)	T <sub>C</sub> = 70 °C		32 <sup>e</sup>		
Continuous Diam Current (1) = 173 C)	T <sub>A</sub> = 25 °C		12 <sup>b, c</sup>	A	
	T <sub>A</sub> = 70 °C		11 <sup>b, c</sup>		
Pulsed Drain Current		I <sub>DM</sub>	110		
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	26		
Single Pulse Avalanche Energy	L = 0.1 IIIA	E <sub>AS</sub>	45	mJ	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	- I <sub>S</sub>	35 <sup>a, e</sup>	Α	
	T <sub>A</sub> = 25 °C		30 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C	- - P <sub>D</sub>	30		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C		19	w	
	T <sub>A</sub> = 25 °C		3.45 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C		2.3 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	$R_{thJA}$	33	43	°C/W
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	3	5	C/VV

#### Notes:

- a. Based on T<sub>C</sub> = 25 °C. b. Surface mounted on 1" x 1" FR4 board.

- c. t = 10 s.
  d. Maximum under steady state conditions is 90 °C/W.
  e. Calculated based on maximum junction temperature.



Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu A$	60			V	
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA		35		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$\Delta V_{GS(th)}/T_{J}$		- 5.5		mv/ C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Cata Valta na Duain Commant	I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1		
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10 µA		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	35			Α	
D 1 0 0 0 1 1 2 1 3	ь	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		13	15	mΩ	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		15.5	20		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 10 A		90		S	
Dynamic <sup>b</sup>					•	•	
Input Capacitance	C <sub>iss</sub>			739		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		185			
Reverse Transfer Capacitance	C <sub>rss</sub>			16			
Total Gate Charge	Qg			15.3		nC	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		1.5			
Gate-Drain Charge	Q <sub>gd</sub>			3.7			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		1.5		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			6			
Rise Time	t <sub>r</sub>	$V_{DD}$ = 30 V, $R_L$ = 1.5 $\Omega$		2.8		ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{D} \approx 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 3 \Omega$		19			
Fall Time	t <sub>f</sub>			3			
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			35	A	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				110		
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1 A		0.6	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			55	88	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	- 10 A 45/45 - 100 A/1/2 T - 25 °C		75	110	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A, di/dt} = 100 \text{ A/µs, T}_J = 25 ^{\circ}\text{C}$		35			
Reverse Recovery Rise Time t <sub>b</sub>				30		ns	

#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

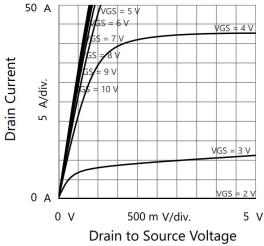
a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

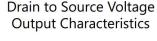
b. Guaranteed by design, not subject to production testing.

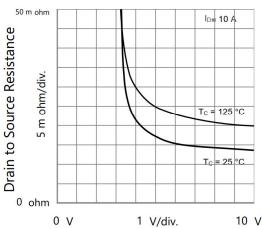


## TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25 °C, unless otherwise noted)

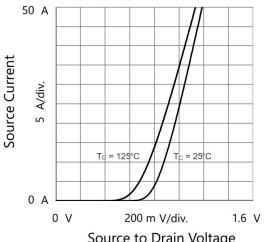
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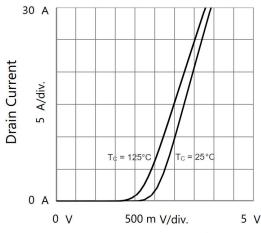




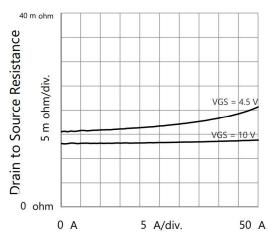
# Gate to Source Voltage Drain to Source Resistance vs. Gate to Source Voltage



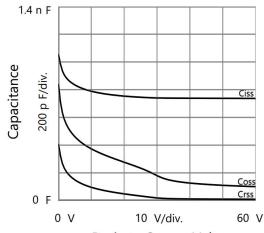
Source to Drain Voltage Body Diode Forward Characteristics



Gate to Source Voltage Transfer Characteristics



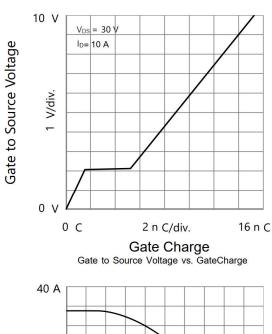
Drain Current
Drain to Source Resistance vs. Drain Current

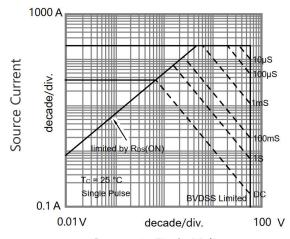


Drain to Source Voltage Capacitances

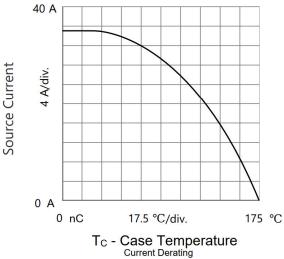
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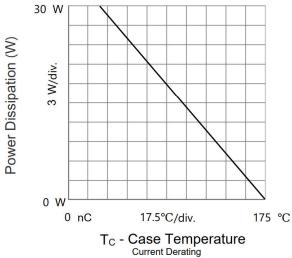
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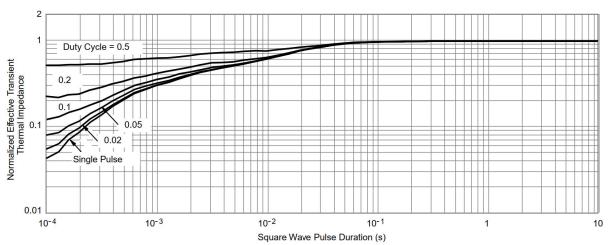




Source to Drain Voltage Safe Operating Area, Junction-to-Ambient







Normalized Thermal Transient Impedance, Junction-to-Case





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